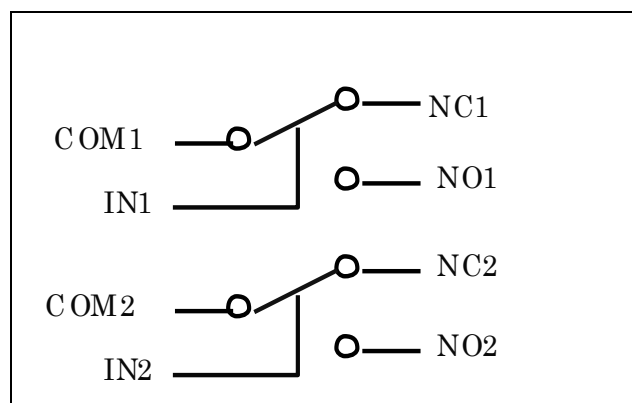


Small Plastic Package, Dual SPDT Analog Switch

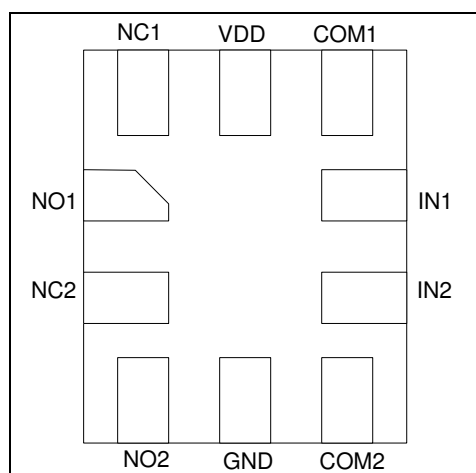
Features

- CMOS Technology for Bus and Analog Applications
- Low On-Resistance: 0.45Ω
- Wide V_{DD} Range: 1.65V to 4.2V
- Rail-to-Rail Signal Range
- High Off Isolation: -83dB @ 100kHz
- Crosstalk Rejection Reduces Signal Distortion: -108dB @ 100kHz
- Break-Before-Make Switching
- Extended Industrial Temperature Range: -40°C to 85°C
- ESD protection : 4kV(HBM)
- Packaging (Pb-free & Green):
-10-pin UQFN (ZM), 1.4mm × 1.8mm

Functional Block Diagram



Pin Configuration (top view)



Description

PI3A2268 is a dual fast single-pole double throw (SPDT) CMOS switch. It can be used as an analog switch or as a low-delay bus switch. Specified over a wide operating power supply voltage, 1.65V to 4.2V, the PI3A2268 has an On-Resistance of 0.45Ω at +4.2V.

Break-before-make switching prevents both switches being enabled simultaneously. This eliminates signal disruption during switching.

Applications

- Cell Phones
- PDAs
- MP3 Players
- Portable Instrumentation
- Computer Peripherals
- Speaker Headset Switching
- Power Routing
- Relay Replacement
- Audio and Video Signal Routing
- PCMCIA Cards
- Modems

Pin Description

Pin no	Name	Description
1	NO1	Data Port (Normally open)
2	NC2	Data Port (Normally closed)
3	NO2	Data Port (Normally open)
4	GND	Ground
5	COM2	Common Output / Data Port
6	IN2	Logic Control
7	IN1	Logic Control
8	COM1	Common Output / Data Port
9	V_{DD}	Positive Power Supply
10	NC1	Data Port (Normally closed)

Logic Function Table

Logic Input (IN_x)	Function
0	NC_x Connected to COM_x
1	NO_x Connected to COM_x

Note: $x = 1$ or 2

Maximum Ratings

Storage Temperature.....	-65°C to +150°C
Ambient Temperature with Power Applied.....	-40°C to +85°C
Supply Voltage V_{DD}	-0.5V to +4.6V
Control Input Voltage V_{INx}	0V to +4.6V
DC Input Voltage V_{INPUT}	-0.5V to +4.6V
Continuous Current NO_NC_COM_.....	±300mA
Peak Current NO_NC_COM_	
(pulsed at 1ms 50% duty cycle)	±400mA
Peak Current NO_NC_COM_	
(pulsed at 1ms 10% duty cycle)	±500mA
ESD(HBM)	4kV

Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

Control input must be held HIGH or LOW; it must not float.

Recommended Operating Conditions

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
V_{DD}	Operating Voltage	-	1.65	-	4.2	V
V_{IN}	Control Input Voltage	-	0	-	V_{DD}	V
V_{INPUT}	Switch Input Voltage	-	-0.3	-	4.2	V
T_A	Operating Temperature	-	-40	25	85	°C
t_r, t_f	Input Rise and Fall Time	-	0	-	10	ns/V

DC Electrical Characteristics

+3.0V Supply ($V_{DD} = 2.7V$ to $3.6V$, $V_{IH} = +1.6V$, $V_{IL} = +0.4V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$, unless otherwise noted. Typical values are at $3.0V$ and $+25^{\circ}C$.)

Parameter	Symbol	Test Conditions	TEMP	Min.	Typ.	Max.	Units	
ANALOG SWITCH								
Analog Signal Range	V _{NO} , V _{NC} , V _{COM}	-	-40 °C to 85 °C	0	-	V _{DD}	V	
On-Resistance	R _{ON}	V _{DD} = 2.7V, I _{COM} = 100mA, V _{NO} or V _{NC} =1V, Test Circuit 1	+25°C	-	0.55	0.9	Ω	
			-40 °C to 85 °C	-	0.55	1		
On-Resistance Match Between Channels	ΔR _{ON}	V _{DD} = 2.7V, I _{COM} = 100mA, V _{NO} or V _{NC} =1V, Test Circuit 1	+25°C	-	0.05	0.22	Ω	
			-40 °C to 85 °C	-	0.05	0.25		
On-Resistance Flatness	R _{ONF}	V _{DD} = 2.7V, I _{COM} = 100mA, V _{NO} or V _{NC} = 1V, 2.5V, Test Circuit 1	+25°C	-	0.1	0.22	Ω	
			-40 °C to 85 °C	-	0.1	0.26		
Source Off Leakage Current	I _{OFF (NO)} or I _{OFF (NC)}	V _{DD} =3.6V, V _{NO} or V _{NC} = 3.3V/0.3V, V _{COM} = 0.3V/3.3V	-40 °C to 85 °C	-	-	1	μA	
Channel On Leakage Current	I _{NC(ON)} , I _{NO(ON)} , I _{COM (ON)}	V _{DD} = 3.6V, V _{NO} or V _{NC} = 3V/ 0.3V, V _{COM} = 3V/0.3V, or floating	-40 °C to 85 °C	-	-	1		
DIGITAL INPUTS								
Input Logic High	V _{IH}	-	-40 °C to 85 °C	1.2	-	-	V	
Input Logic Low	V _{IL}	-	-40 °C to 85 °C	-	-	0.5		
IN Input Leakage Current	I _{IN}	V _{DD} = 2.7V, V _{IN} =0 or 2.7V	-40 °C to 85 °C	-	-	1	μA	
DYNAMIC CHARACTERISTICS								
Turn-On Time	t _{ON}	V _{IH} =1.5V, V _{IL} =0V, See Test Circuit Figure 2.	+25°C	-	15	-	ns	
Turn-Off Time	t _{OFF}	V _{IH} =1.5V, V _{IL} =0V, See Test Circuit Figure 2.	+25°C	-	20	-	ns	
Break-Before-Make Delay	t _D	V _{IH} =1.5V, V _{IL} =0V, See Test Circuit Figure 3.	+25°C	-	10	-	ns	
COM-NC/NO and NC-NO Isolations	O _{ISO}	V _{BIAS} =1.5V, V _{IN} =0dBm, V _{IH} =1.5V, V _{IL} =0V. See Test Circuit Figure 4 & Figure 5.	100kHz	+25°C	-	-81	-	dB
			1MHz	+25°C	-	-61	-	
			10MHz	+25°C	-	-39	-	
Channel-to-Channel Crosstalk	X _{TALKD}	V _{BIAS} = 1.5V, V _{DD} =0dBm, V _{IH} =1.5V, V _{IL} =0V See Test Circuit Figure 6.	100kHz	+25°C	-	-108	-	dB
			1MHz	+25°C	-	-110	-	
			10MHz	+25°C	-	-90	-	
3dB Bandwidth	f _{3dB}	V _{BIAS} = 1.5V, V _{IN} =0dBm, V _{IH} =1.5V, V _{IL} =0V. See Test Circuit Figure 7.	+25°C	-	79	-	MHz	
Charge Injection Select Input to Common I/O	Q	V _{IN} = GND, R _S = 0, C _L = 1nF, V _{IH} =1.5V, V _{IL} =0V See Test Circuit Figure 8.	+25°C	-	35	-	pC	

+4.2V Supply ($V_{DD} = 4.2V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$, unless otherwise noted. Typical values are at $4.2V$ and $+25^{\circ}C$.)

Parameter	Symbol	Test Conditions	TEMP	Min.	Typ.	Max.	Units	
ANALOG SWITCH								
Analog Signal Range	V _{NO} , V _{NC} , V _{COM}	-	-40 °C to 85 °C	0	-	V _{DD}	V	
On-Resistance	R _{ON}	V _{DD} = 4.2V, I _{COM} = 100mA, V _{NO} or V _{NC} =1V, Test Circuit 1	+25°C -40 °C to 85 °C	- -	0.45 0.45	0.75 0.85	Ω	
On-Resistance Match Between Channels	ΔR _{ON}	V _{DD} = 4.2V, I _{COM} = 100mA, V _{NO} or V _{NC} =1V, Test Circuit 1	+25°C -40 °C to 85 °C	- -	0.05 0.05	0.18 0.23	Ω	
On-Resistance Flatness	R _{ONF}	V _{DD} = 4.2V, I _{COM} = 100mA, V _{NO} or V _{NC} = 1V, 2.5V, Test Circuit 1	+25°C -40 °C to 85 °C	- -	0.1 0.1	0.22 0.26	Ω	
Source Off Leakage Current	I _{OFF (NO)} or I _{OFF (NC)}	V _{DD} = 4.2V, V _{NO} or V _{NC} = 3.3V/0.3V, V _{COM} = 0.3V/3V	-40 °C to 85 °C	-	-	1	μA	
Channel On Leakage Current	I _{NC(ON)} , I _{NO(ON)} , I _{COM} (ON)	V _{DD} = 4.2V, V _{NO} or V _{NC} = 3V/ 0.3V, V _{COM} = 3V/0.3V, or floating	-40 °C to 85 °C	-	-	1		
DIGITAL INPUTS								
Input Logic High	V _{IH}	-	-40 °C to 85 °C	1.2	-	-	V	
Input Logic Low	V _{IL}	-	-40 °C to 85 °C	-	-	0.5		
IN Input Leakage Current	I _{IN}	V _{DD} = 4.2V, V _{IN} =0 or 4.2V	-40 °C to 85 °C	-	-	1	μA	
DYNAMIC CHARACTERISTICS								
Turn-On Time	t _{ON}	V _{IH} =3V, V _{IL} =0V, See Test Circuit Figure 2.		+25°C	-	13	-	ns
Turn-Off Time	t _{OFF}	V _{IH} =3V, V _{IL} =0V, See Test Circuit Figure 2.		+25°C	-	12	-	ns
Break-Before-Make Delay	t _D	V _{IH} =3V, V _{IL} =0V, See Test Circuit Figure 3.		+25°C	-	8	-	ns
COM-NC/NO and NC-NO Isolations	O _{ISO}	V _{BIAS} = 2.1V, V _{IN} =0dBm, V _{IH} =3V, V _{IL} =0V. See Test Circuit Figure 4 & Figure 5.	100kHz	+25°C	-	-83	-	dB
			1MHz	+25°C	-	-61	-	
			10MHz	+25°C	-	-39	-	
Channel-to-channel Crosstalk	X _{TALK}	V _{BIAS} = 2.1V, V _{IN} =0dBm, V _{IH} =3V, V _{IL} =0V See Test Circuit Figure 6.	100kHz	+25°C	-	-108	-	dB
			1MHz	+25°C	-	-110	-	
			10MHz	+25°C	-	-90	-	
3dB Bandwidth	f _{3dB}	V _{BIAS} = 2.1V, V _{IN} =0dBm, V _{IH} =3V, V _{IL} =0V. See Test Circuit Figure 7.		+25°C	-	84	-	MHz
Charge Injection Select Input to Common I/O	Q	V _{IN} = GND, R _S = 0, C _L = 1nF, V _{IH} =3V, V _{IL} =0V See Test Circuit Figure 8.		+25°C	-	50	-	pC
POWER REQUIREMENTS								
Power Supply Range	V _{DD}	-		-40 °C to 85 °C	1.65	-	4.2	V
Power Supply Current	I _{CC}	V _{DD} =4.2V, V _{IN} =0V or V _{DD}		-40 °C to 85 °C	-	-	1	μA

Capacitance

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
NC Off Capacitance	$C_{NC(OFF)}$	$f = 1MHz$, See Test Circuit Figure 9.	-	20	-	pF
NO Off Capacitance	$C_{NO(OFF)}$	$f = 1MHz$, See Test Circuit Figure 9.	-	20	-	
NC On Capacitance	$C_{NC(ON)}$	$f = 1MHz$, See Test Circuit Figure 10.	-	55	-	
NO On Capacitance	$C_{NO(ON)}$	$f = 1MHz$, See Test Circuit Figure 10.	-	55	-	

Test Circuits and Timing Diagrams

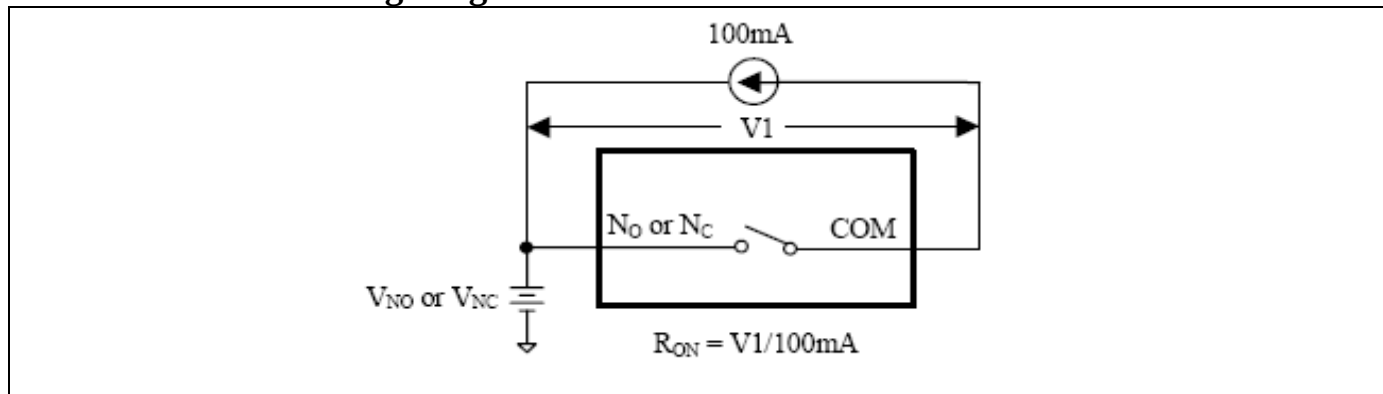


Figure 1. On Resistance

Notes:

1. Unused input (NC or NO) must be grounded.

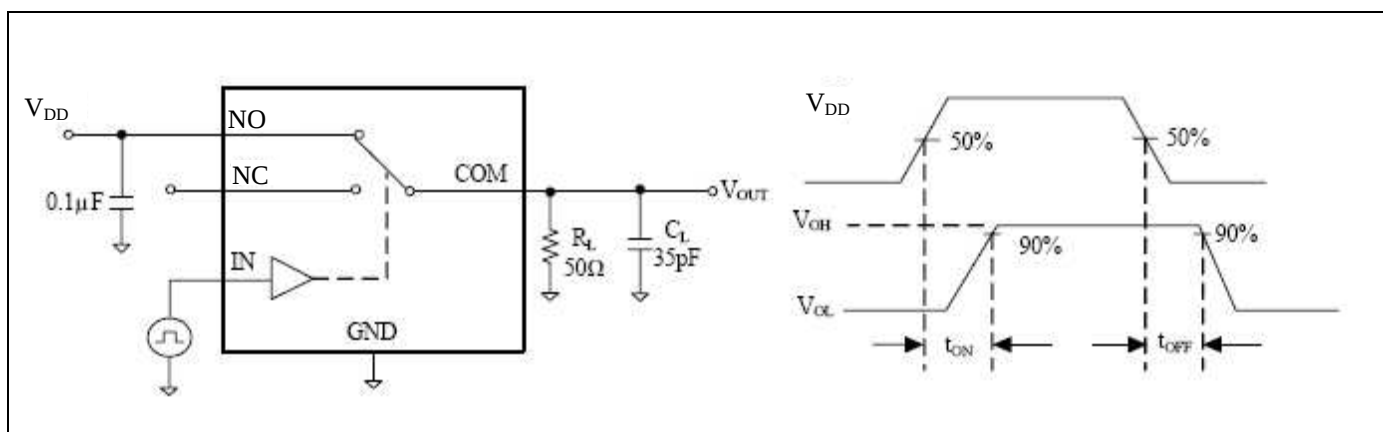


Figure 2. Switching Times

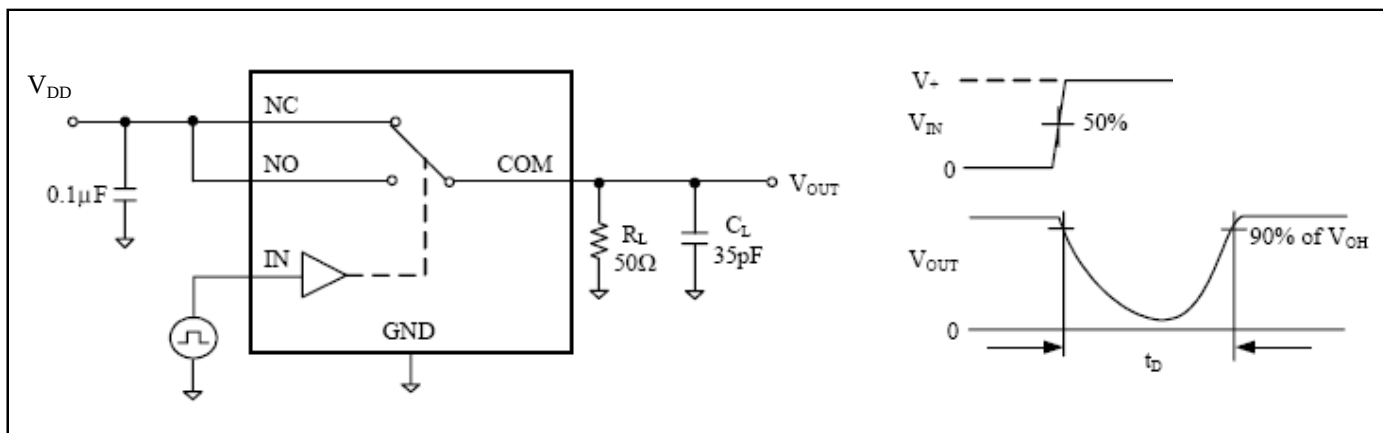


Figure 3. Break Before Make Interval Timing

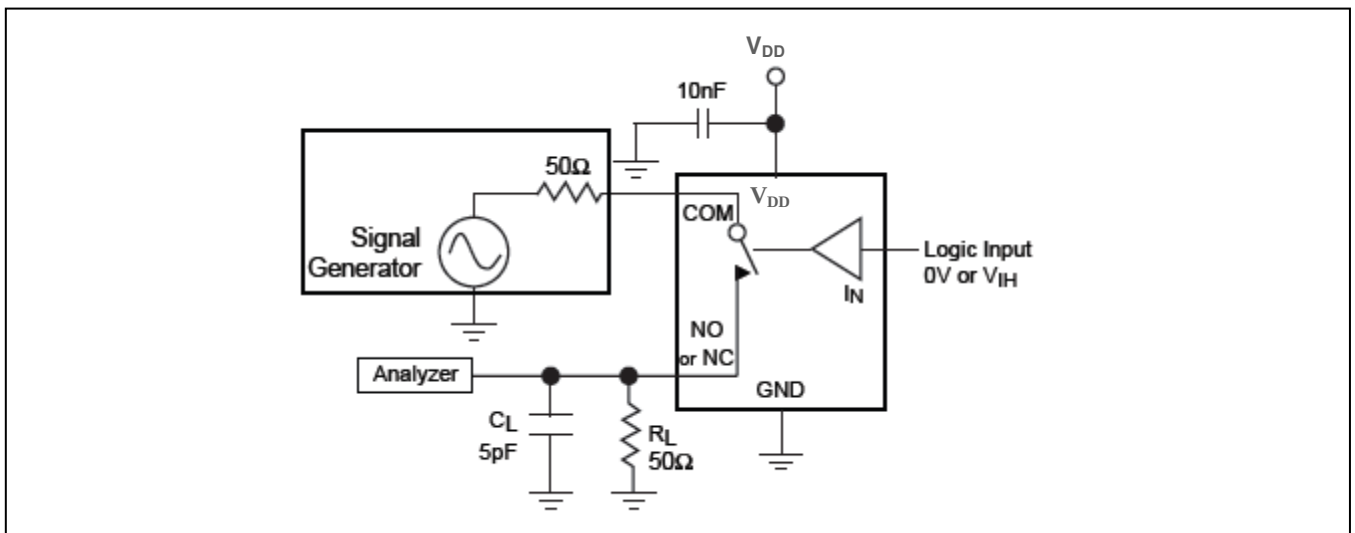


Figure 4. COM-NC/NO Isolation

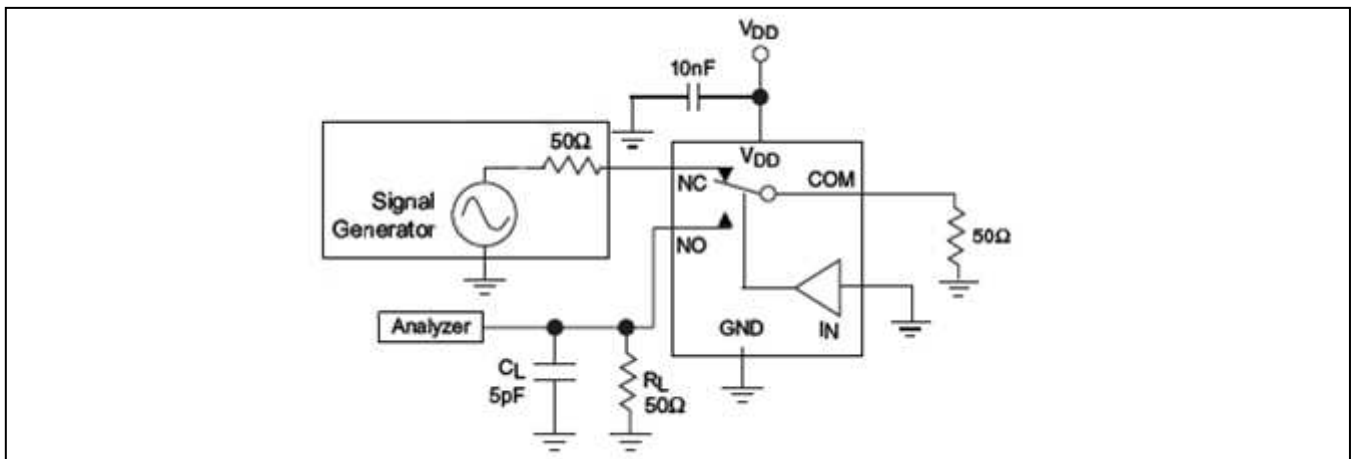


Figure 5. NC-NO Isolation

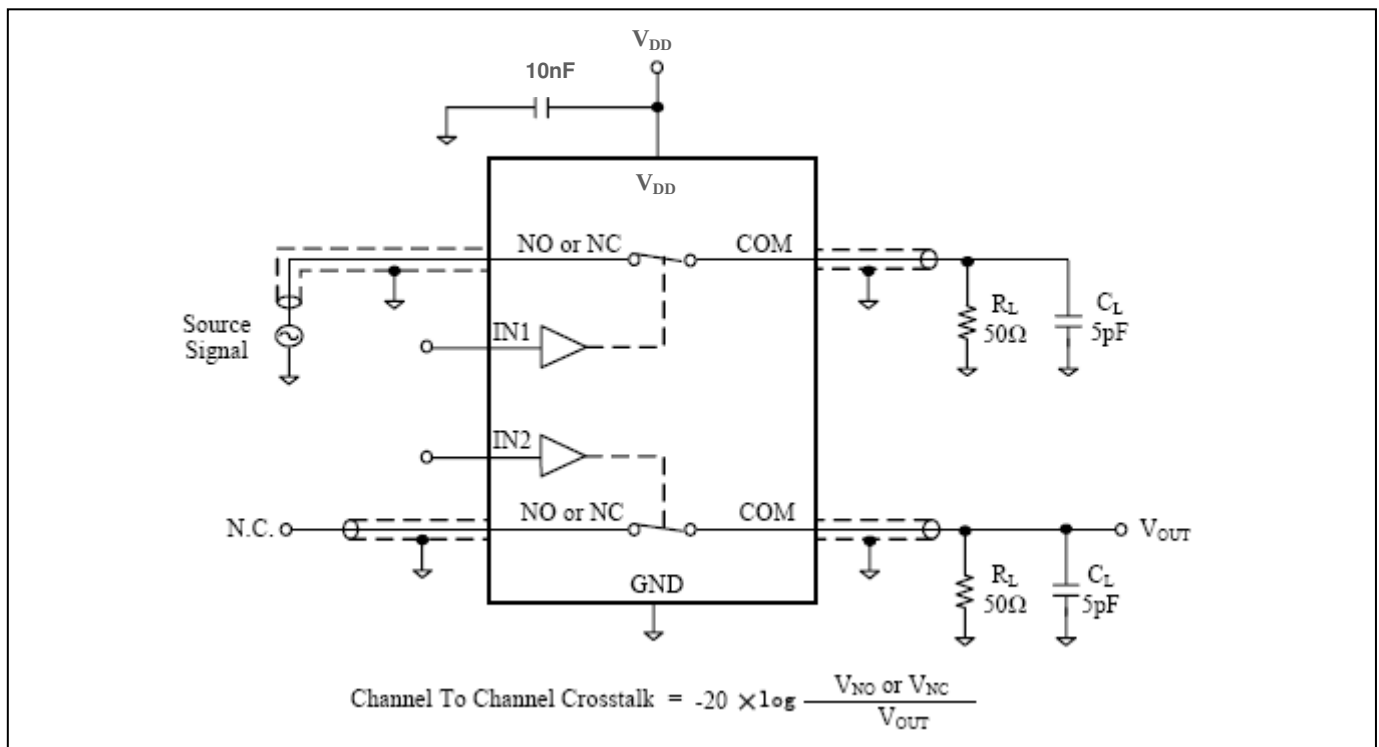


Figure 6. Channel-to-Channel Crosstalk

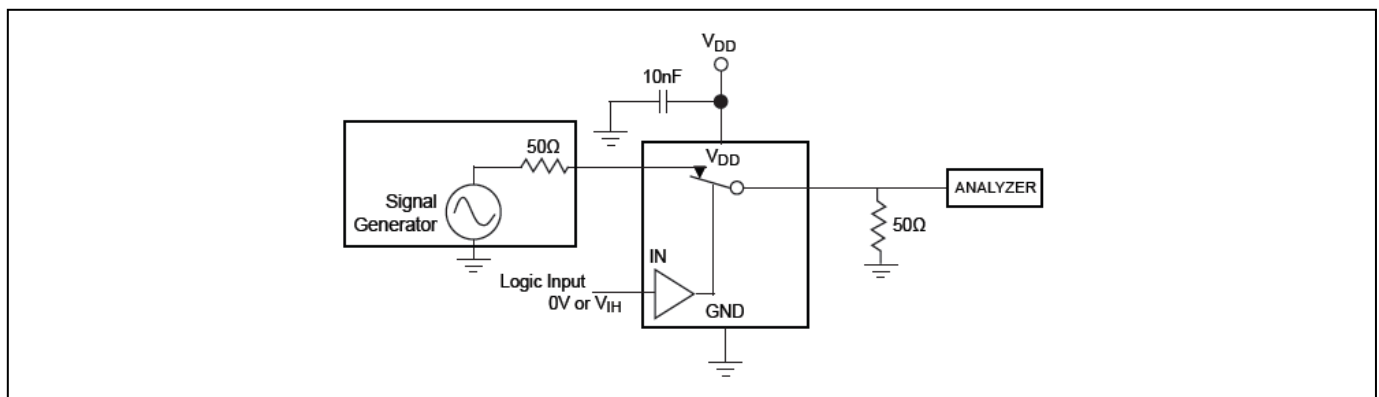


Figure 7. Bandwidth

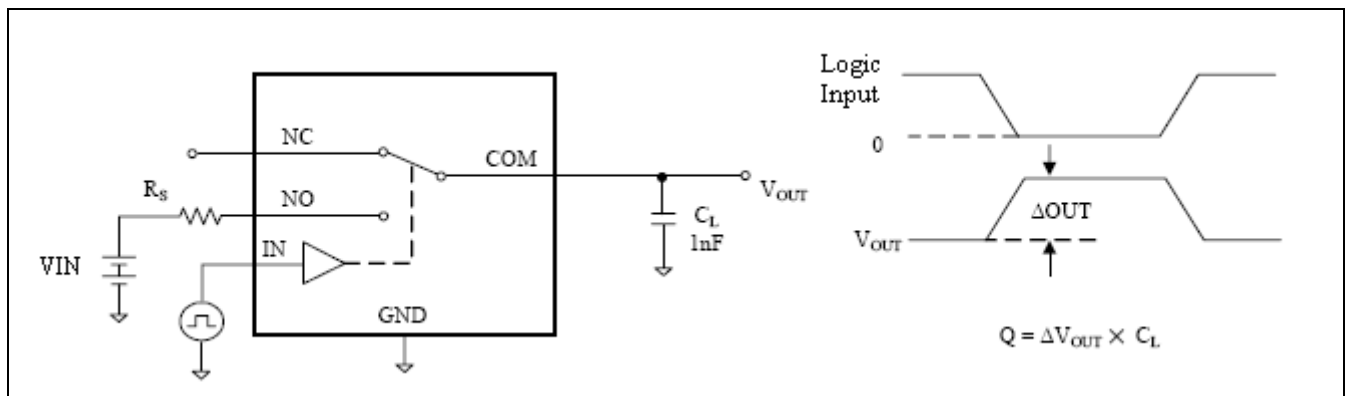


Figure 8. Charge Injection

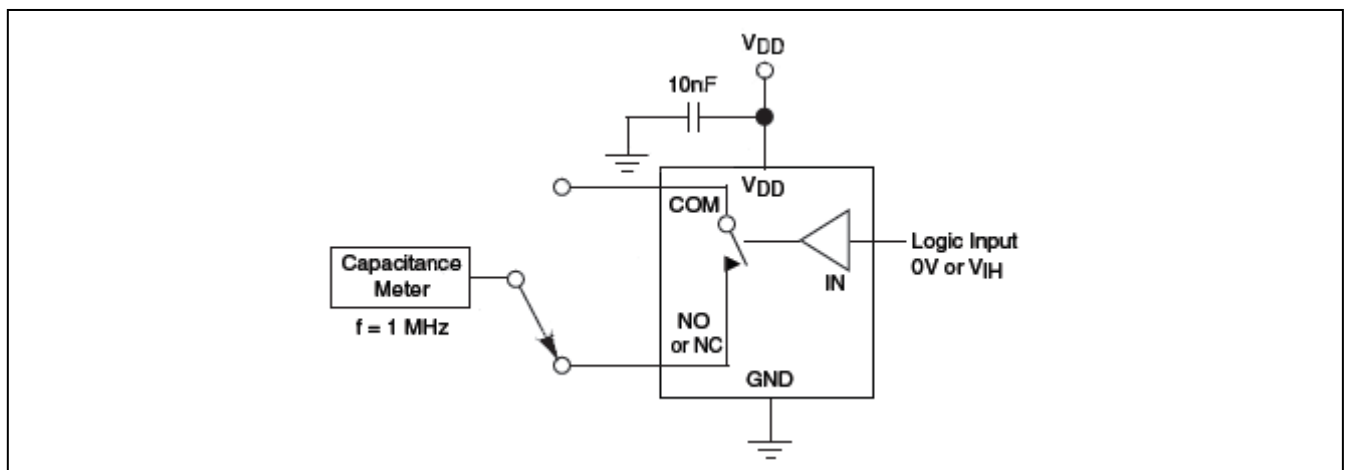


Figure 9. Channel Off Capacitance

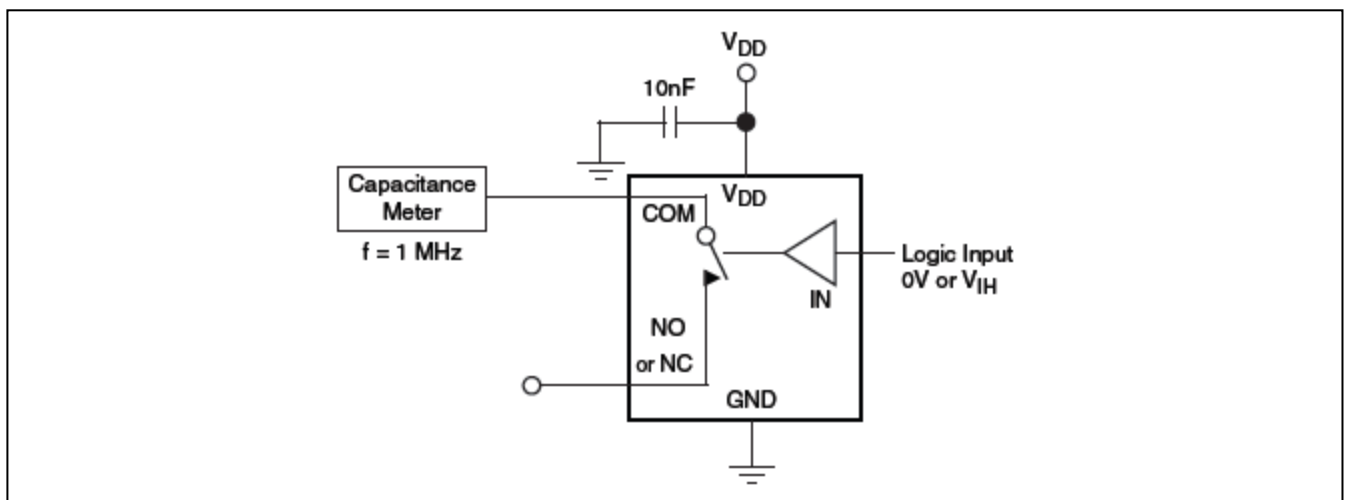
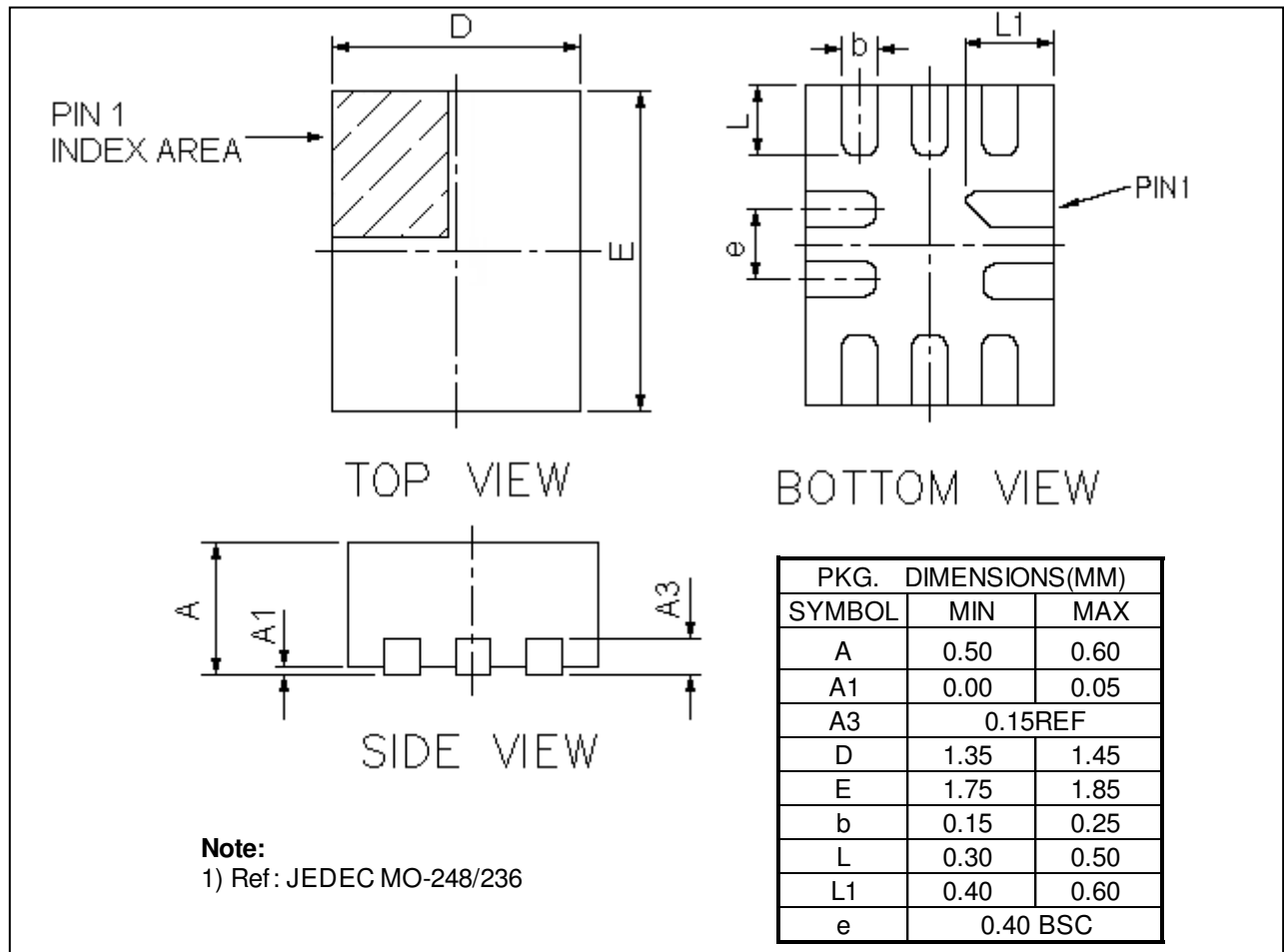
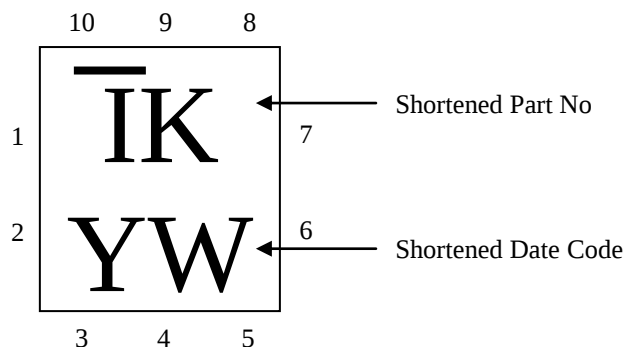


Figure 10. Channel On Capacitance

Mechanical Information 10-pin UQFN (ZM10)



Marking Description



Ordering Information

Part Number	Packaging Code	Package
PI3A2268ZME	ZM	Lead Free and Green UQFN-10

Notes:

- E = Pb-free and Green
- Adding X Suffix= Tape/Reel

Pericom Semiconductor Corporation • 1-800-435-2336 • www.pericom.com

Pericom reserves the right to make changes to its products or specifications at any time, without notice, in order to improve design or performance and to supply the best possible product. Pericom does not assume any responsibility for use of any circuitry described other than the circuitry embodied in Pericom product. The company makes no representations that circuitry described herein is free from patent infringement or other rights, of Pericom.